

**Search Notes**

Application/Control No.

10/821,969

Examiner

Jinhee J. Lee

Applicant(s)/Patent under  
Reexamination

WATSON ET AL.

Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner
715	757, 850- 853, 836, 800, 801	6/10/2007	LEE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR